

NCE N-Channel Enhancement Mode Power MOSFET

Description

The NCE0117K uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

V_{DS} =100V,I_D =17A

 $R_{DS(ON)} < 70 m\Omega @ V_{GS} = 10V \quad (Typ:56 m\Omega)$

 $R_{DS(ON)} < 85m\Omega$ @ V_{GS} =4.5V (Typ:65m Ω)

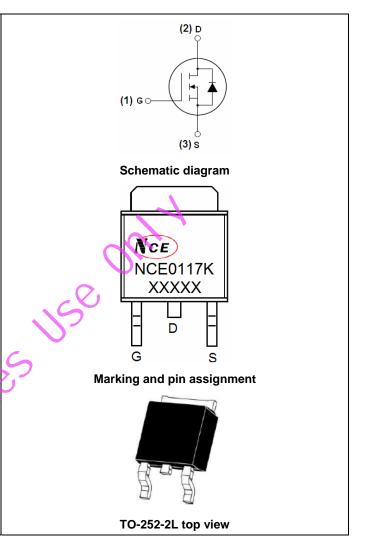
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Power switching application
- Hard switched and high frequency circuits

100% UIS TESTED!

100% ΔVds TESTED



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCE0117K	NCE0117K	TO-252-2L	-	-	-

Absolute Maximum Ratings (T_C=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	100	V
Gate-Source Voltage	V _G s	±20	V
Drain Current-Continuous	I _D	17	А
Drain Current-Continuous(T _C =100°C)	I _D (100°ℂ)	12	А
Pulsed Drain Current	I _{DM}	60	А
Maximum Power Dissipation	P _D	55	W
Single pulse avalanche energy (Note 5)	E _{AS}	28	mJ
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}\!\mathbb{C}$



Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	R _{eJC}	2.27	°C/W	1
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Electrical Characteristics (T_C=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	100	110	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μΑ	
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA	
On Characteristics (Note 3)							
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.2	1.8	2.5	V	
Danie Course On Otata Besistance		V _{GS} =10V, I _D =5A	1	- 56	70	m0	
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =3A		65	85	mΩ	
Forward Transconductance	g FS	V _{DS} =5V,I _D =5A	12	-	-	S	
Dynamic Characteristics (Note4)	1						
Input Capacitance	C _{lss}	V 05/410 0V	-	1350	-	PF	
Output Capacitance	Coss	$V_{DS}=25V, V_{GS}=0V,$	-	240	-	PF	
Reverse Transfer Capacitance	C _{rss}	F=1.0MHz	-	180	-	PF	
Switching Characteristics (Note 4)	•	3					
Turn-on Delay Time	t _{d(on)}	NO.	-	13.8	-	nS	
Turn-on Rise Time	t _r	V_{DD} =30V, R_L =15 Ω	-	9.3	-	nS	
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10V, R_{G} =2.5 Ω	-	43.8	-	nS	
Turn-Off Fall Time	t _f		-	11.4	-	nS	
Total Gate Charge	Q_g)/ 00)/I 5A	-	30		nC	
Gate-Source Charge	Q _{gs}	V_{DS} =30V, I_D =5A,	-	6.4	-	nC	
Gate-Drain Charge	Q_{gd}	V _{GS} =10V	-	8.6	-	nC	
Drain-Source Diode Characteristics	1						
Diode Forward Voltage (Note 3)	V_{SD}	V _{GS} =0V,I _S =17A	-	-	1.2	V	
Diode Forward Current (Note 2)	Is		-	-	17	Α	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)					

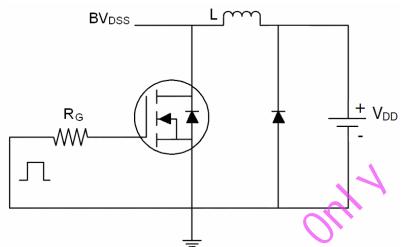
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width ≤ 300μ s, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω

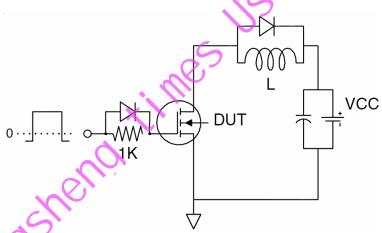


Test Circuit

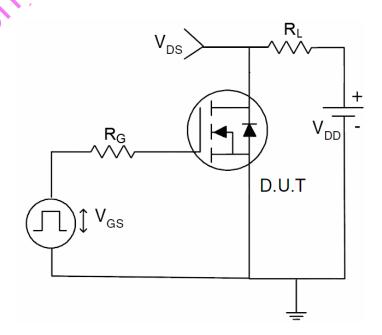
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit







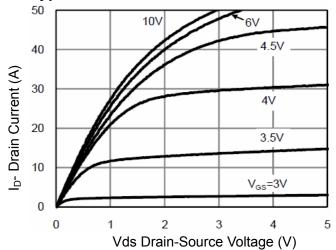


Figure 1 Output Characteristics

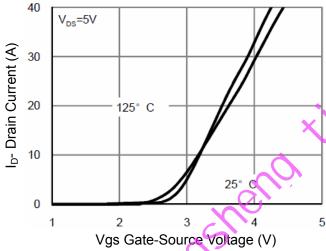


Figure 2 Transfer Characteristics

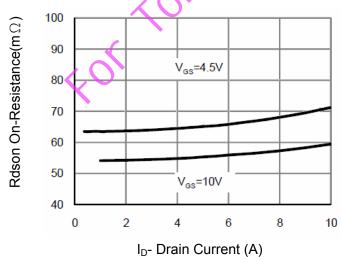


Figure 3 Rdson- Drain Current

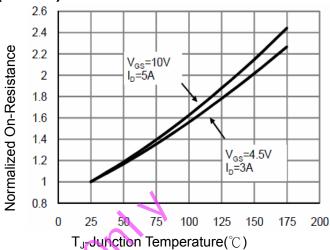


Figure 4 Rdson-JunctionTemperature

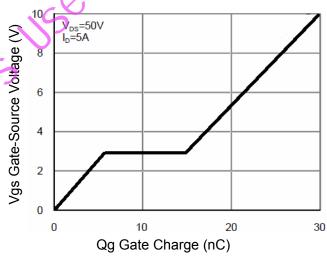


Figure 5 Gate Charge

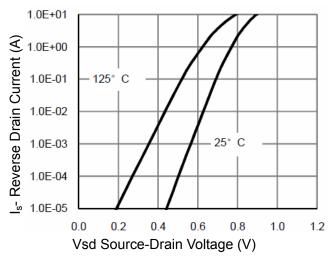


Figure 6 Source- Drain Diode Forward



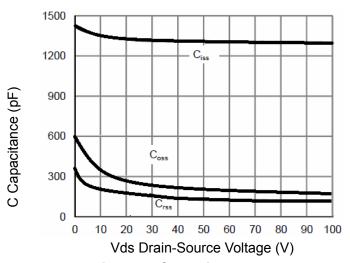


Figure 7 Capacitance vs Vds

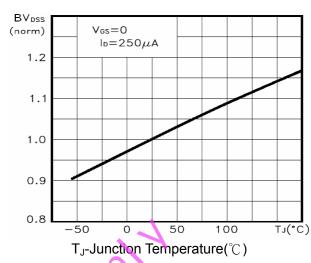


Figure 9 BV_{DSS} vs Junction Temperature

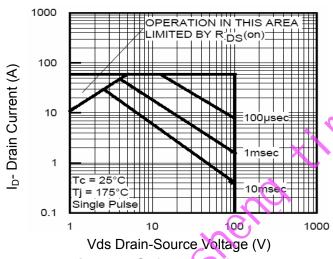


Figure 8 Safe Operation Area

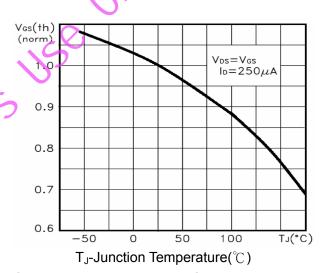


Figure 10 V_{GS(th)} vs Junction Temperature

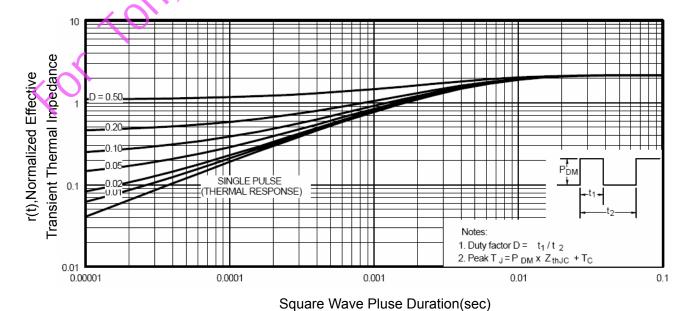
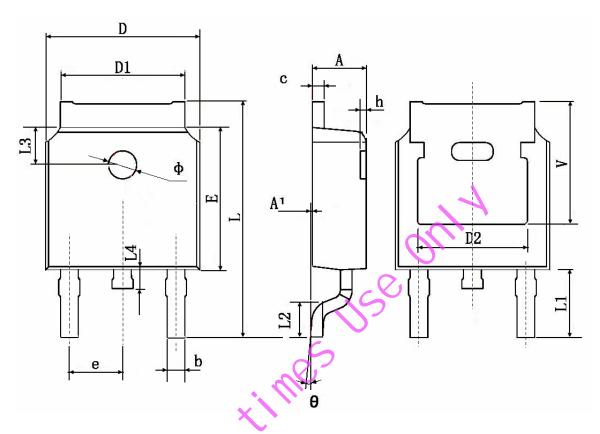


Figure 11 Normalized Maximum Transient Thermal Impedance



TO-252 Package Information



Cumbal	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2 (4.830	4.830 TYP.		TYP.	
√ €)	6.000	6.200	0.236	0.244	
e	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900	2.900 TYP. 0.114		TYP.	
L2	1.400	1.700	0.055	0.067	
L3	1.600	1.600 TYP.		TYP.	
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.350 TYP.		0.211 TYP.		



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